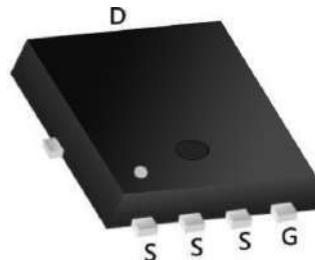


Single N-Channel MOSFET

Features:

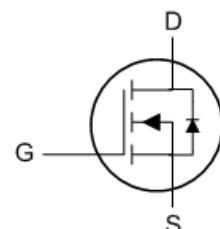
- ★ Advanced Trench MOS Technology
- ★ 100% EAS Guaranteed
- ★ Green Device Available



Applications:

- ★ Synchronous rectification.
- ★ Primary side switching.

PRPAK5X6 Pin Configuration



Product Summary

BVDSS	RDS(on)	ID
80V	6.5mΩ	60A

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	80	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current ^{1,6}	60	A
I _D @T _C =70°C	Continuous Drain Current ^{1,6}	60	A
I _D @T _A =25°C	Continuous Drain Current ^{1,6}	23.8	A
I _D @T _A =70°C	Continuous Drain Current ^{1,6}	19	A
I _{DM}	Pulsed Drain Current ²	170	A
EAS	Single Pulse Avalanche Energy ³	57.8	mJ
I _{AS}	Avalanche Current	34	A
P _D @T _C =25°C	Total Power Dissipation ^{1,4}	104	W
P _D @T _A =25°C	Total Power Dissipation ^{1,4}	6.25	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient($t \leq 10s$) ¹	---	20	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹	---	1.2	°C/W

Electrical Characteristics ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_D=250\mu\text{A}$	80	---	---	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=20\text{A}$	---	4.3	6.5	$\text{m}\Omega$
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=20\text{A}$	---	6.3	8.5	$\text{m}\Omega$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$, $\text{I}_D=250\mu\text{A}$	1.2	---	2.3	V
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=64\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=25\text{ }^{\circ}\text{C}$	---	---	1	uA
		$\text{V}_{\text{DS}}=64\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=55\text{ }^{\circ}\text{C}$	---	---	5	
I_{GSS}	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=\pm 20\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}$, $\text{I}_D=20\text{A}$	---	75	---	S
R_{g}	Gate Resistance	$\text{V}_{\text{DS}}=0\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	0.5	---	Ω
Q_{g}	Total Gate Charge (10V)	$\text{V}_{\text{DS}}=40\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=20\text{A}$	---	40	---	nC
Q_{gs}	Gate-Source Charge		---	7.2	---	
Q_{gd}	Gate-Drain Charge		---	6.5	---	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time	$\text{V}_{\text{DD}}=40\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{R}_{\text{G}}=3\Omega$, $\text{I}_D=20\text{A}$	---	8.3	---	ns
T_{r}	Rise Time		---	4.2	---	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time		---	36	---	
T_{f}	Fall Time		---	6.9	---	
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=40\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	2860	---	pF
C_{oss}	Output Capacitance		---	410	---	
Cr_{ss}	Reverse Transfer Capacitance		---	38	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_{s}	Continuous Source Current ^{1,5}	$\text{V}_{\text{G}}=\text{V}_{\text{D}}=0\text{V}$, Force Current	---	---	60	A
V_{SD}	Diode Forward Voltage ²	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_{\text{s}}=\text{A}$, $\text{T}_J=25\text{ }^{\circ}\text{C}$	---	0.77	1.0	V
t_{rr}	Reverse Recovery Time	$\text{I}_{\text{F}}=20\text{A}$, $d\text{I}/dt=100\text{A}/\mu\text{s}$, $\text{T}_J=25\text{ }^{\circ}\text{C}$	---	27	---	nS
Q_{rr}	Reverse Recovery Charge		---	89	---	nC

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $\text{V}_{\text{DD}}=25\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{L}=0.1\text{mH}$, $\text{I}_{\text{AS}}=34\text{A}$
- 4.The power dissipation is limited by $150\text{ }^{\circ}\text{C}$ junction temperature
- 5.The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.
- 6.The maximum current rating is package limited.

Typical Characteristics

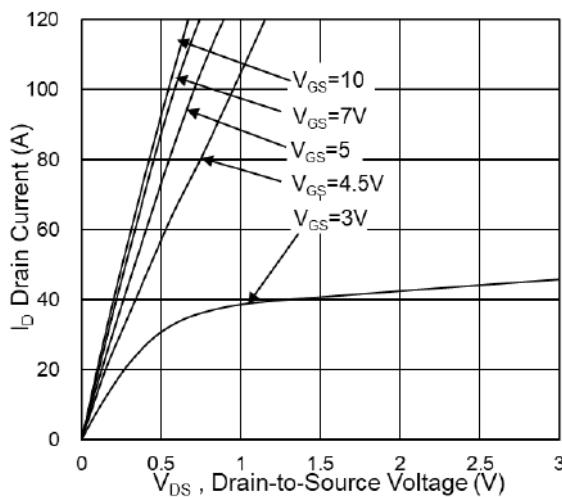


Fig.1 Typical Output Characteristics

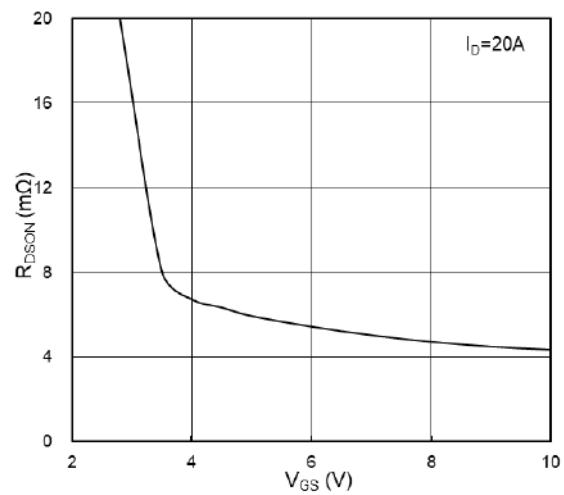


Fig.2 On-Resistance vs G-S Voltage

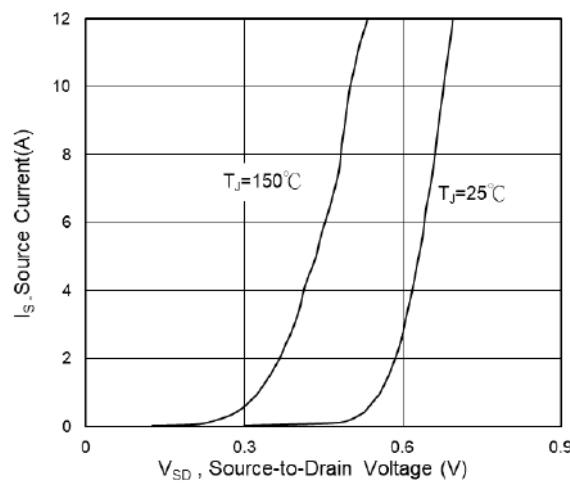


Fig.3 Source Drain Forward Characteristics

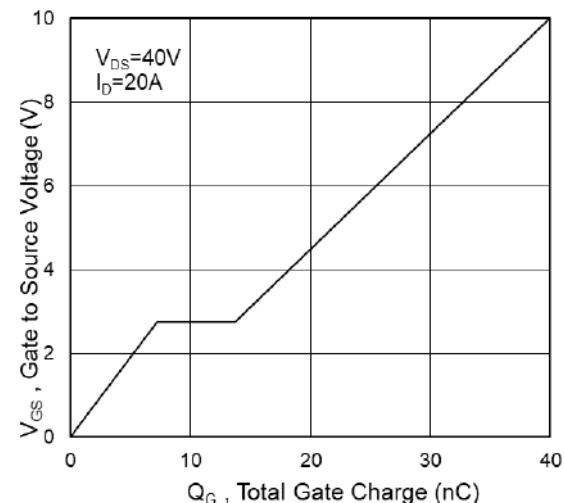


Fig.4 Gate-Charge Characteristics

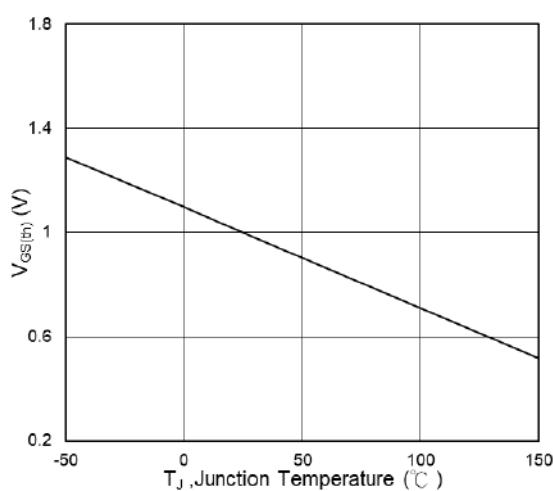


Fig.5 Normalized $V_{GS(th)}$ vs T_J

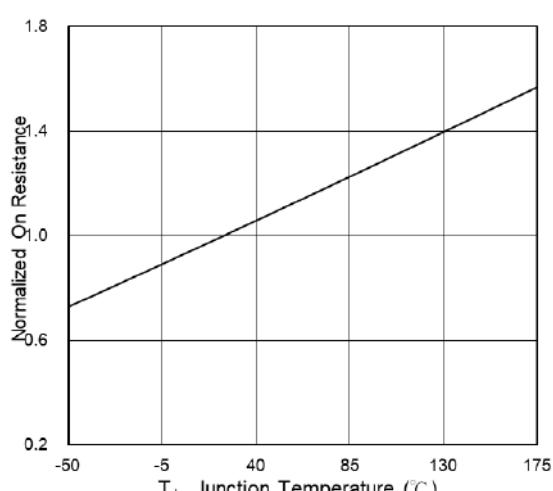


Fig.6 Normalized $R_{DS(on)}$ vs T_J

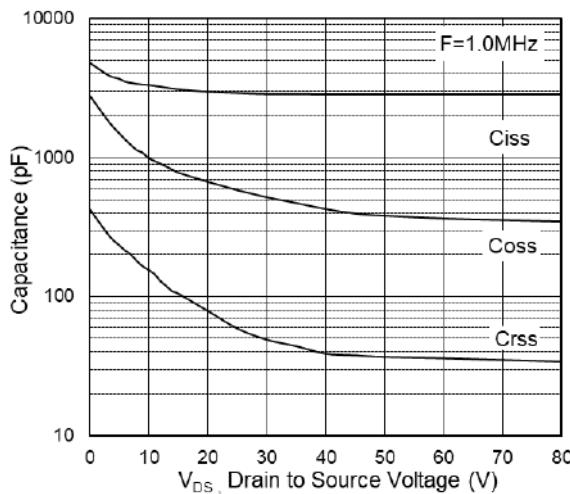


Fig.7 Capacitance

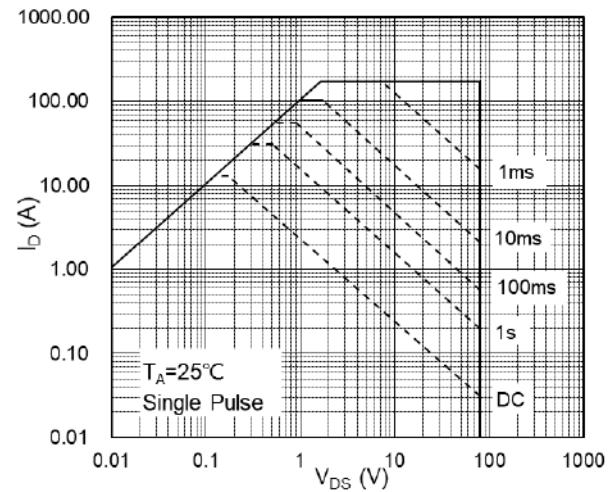


Fig.8 Safe Operating Area

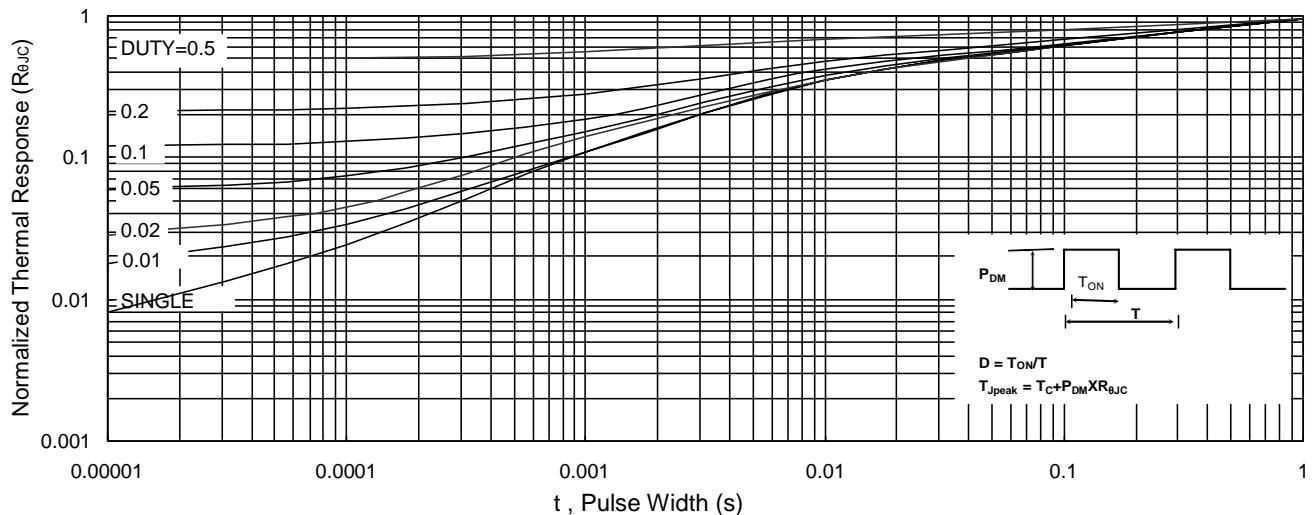


Fig.9 Normalized Maximum Transient Thermal Impedance

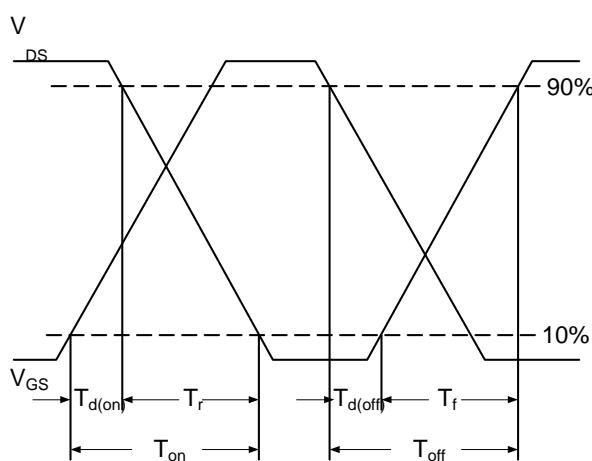


Fig.10 Switching Time Waveform

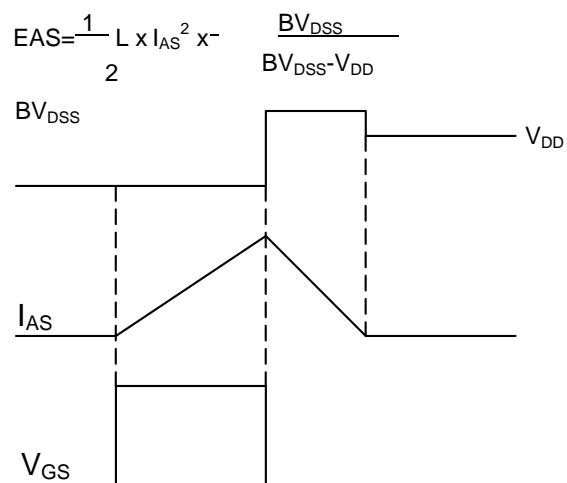


Fig.11 Unclamped Inductive Switching Waveform